

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/682,641 CHANG ET AL.	
		Examiner	Art Unit	Page 1 of 1 Hiep T. Nguyen 2187

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*	C	US-6,563,732	05-2003	Matarrese et al.	365/185.09
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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